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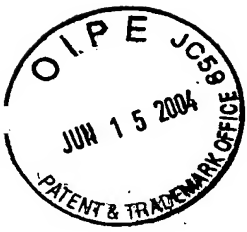
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Hidden Markov Models for Profile Alignment

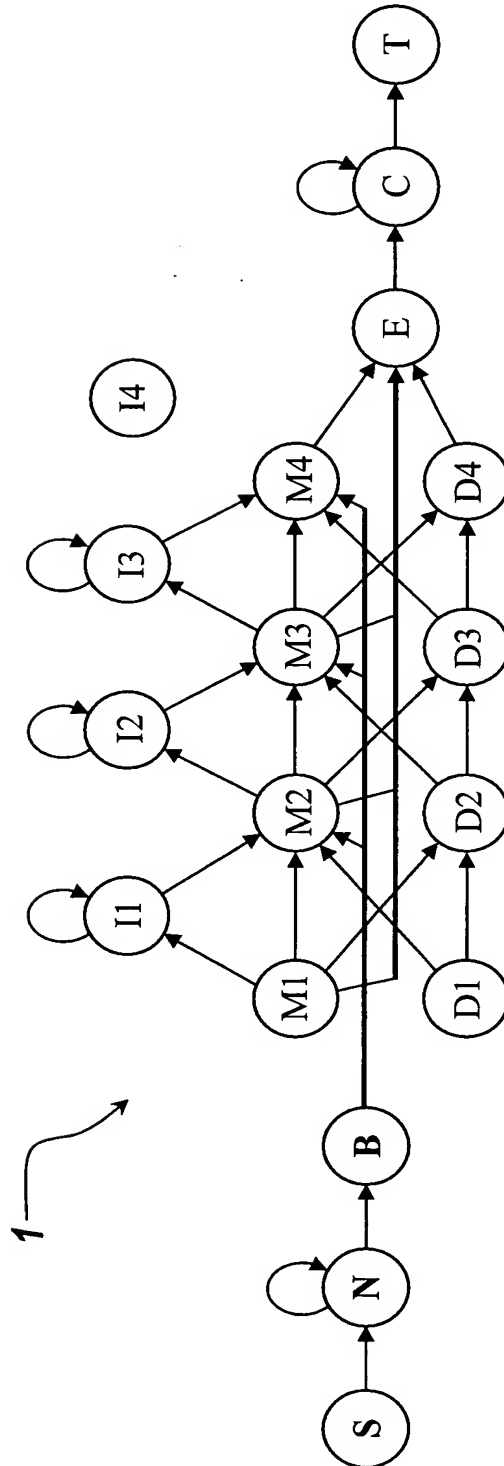


Fig. 1
 (Prior Art)

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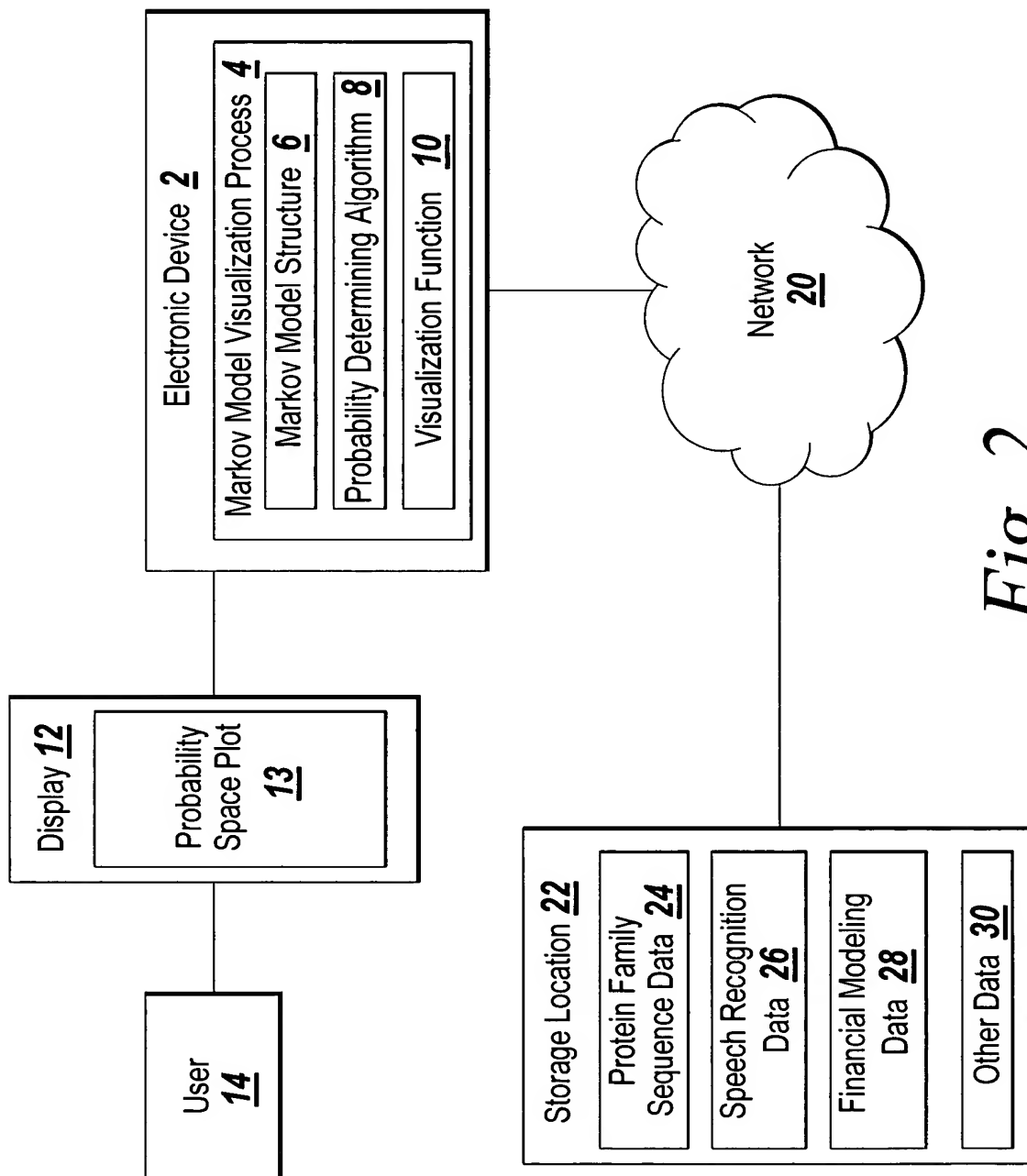


Fig. 2

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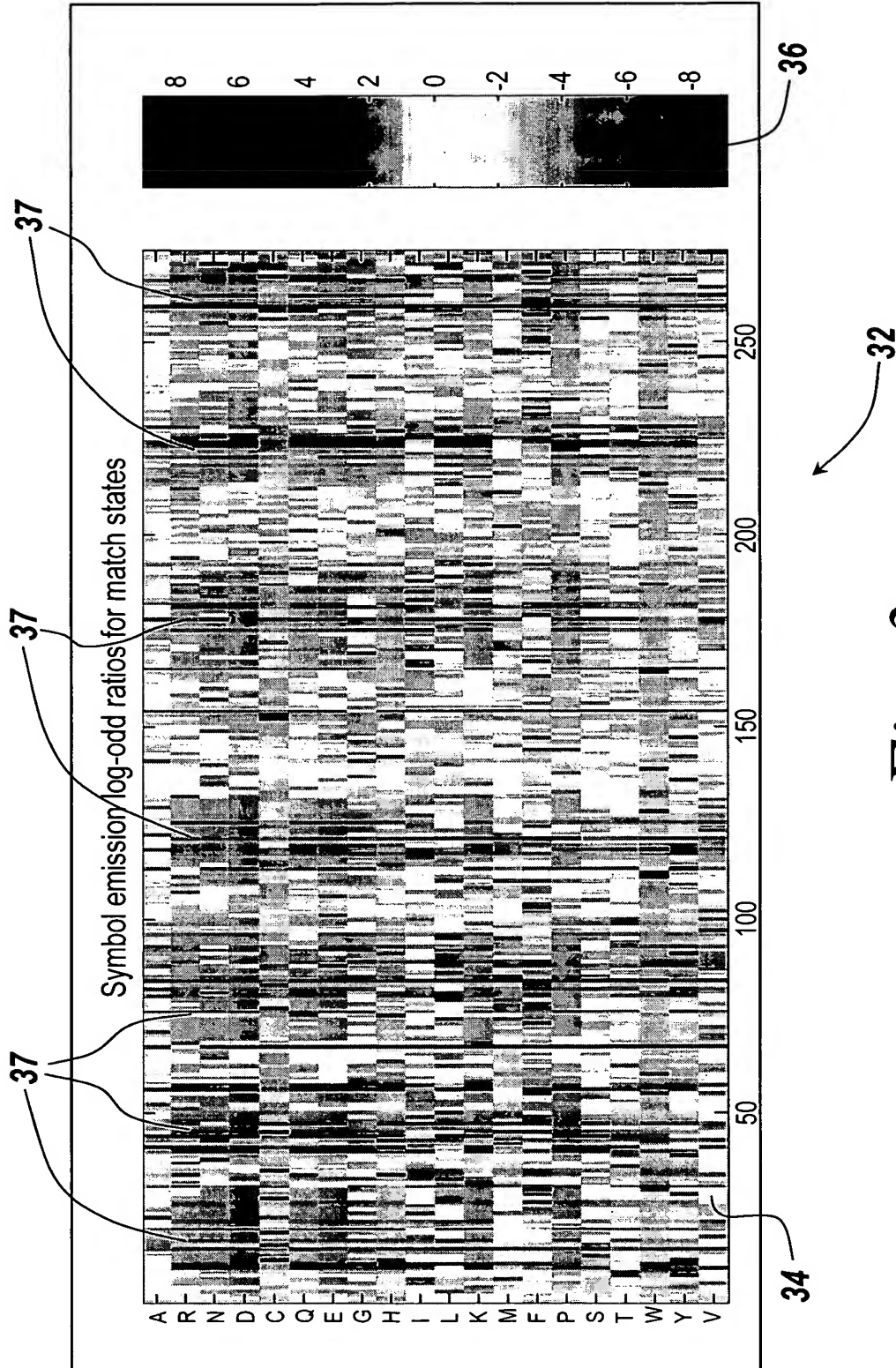
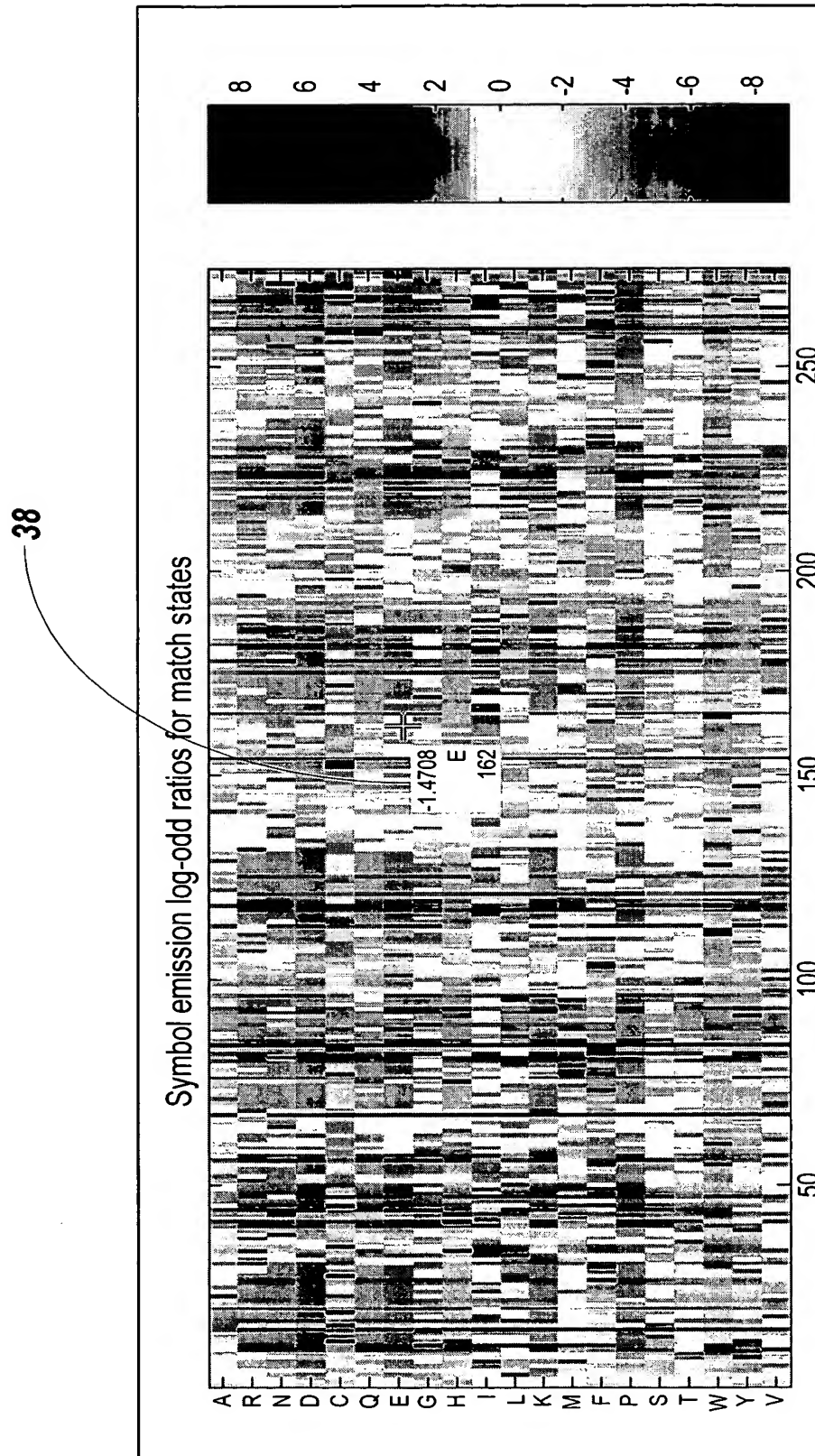


Fig. 3

Inventor: Lucio ANDRADE-CETTO

Title: A SYSTEM AND METHOD FOR VISUALIZING
REPETITIVELY STRUCTURED MARKOV MODELS

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*Fig. 4*

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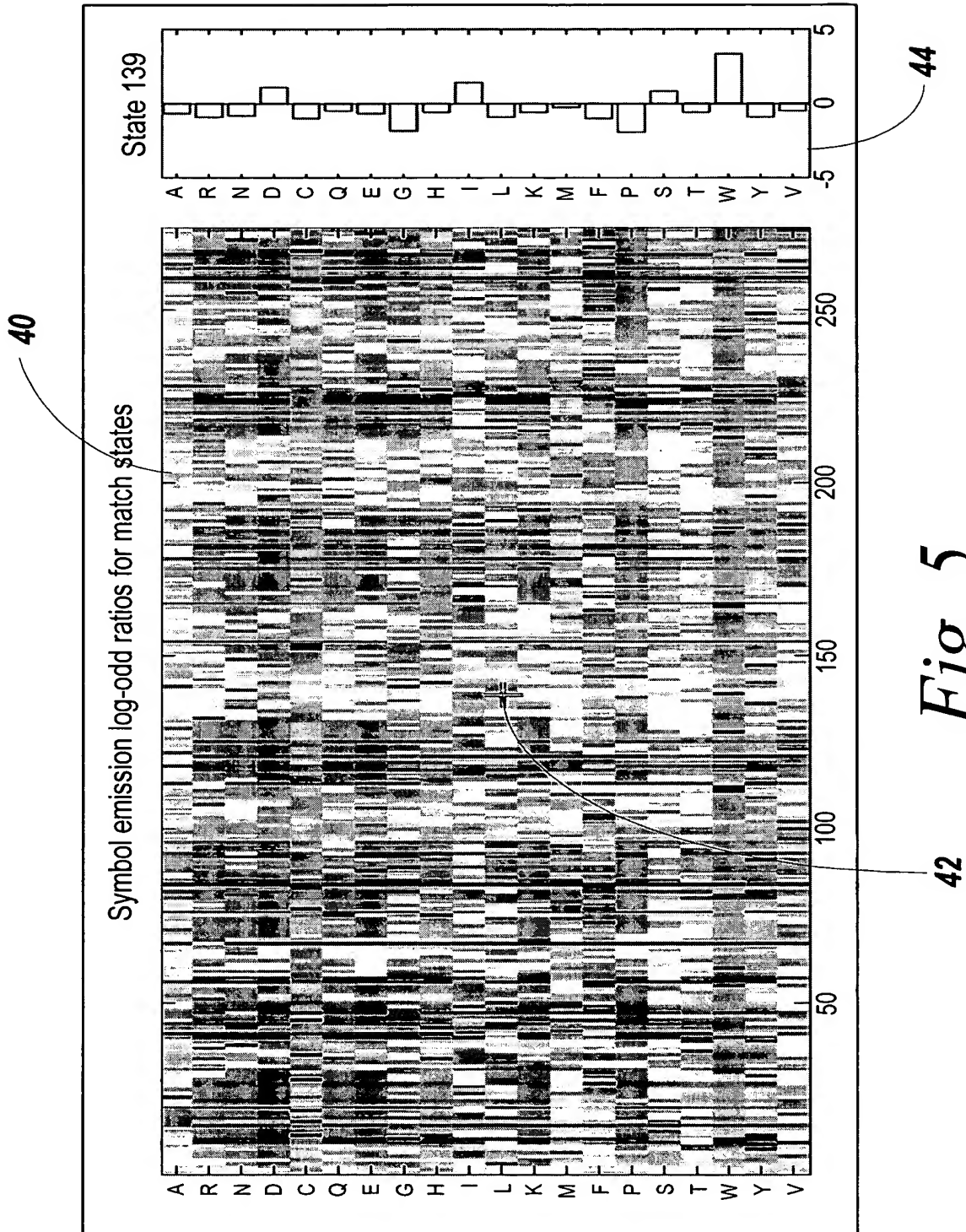


Fig. 5

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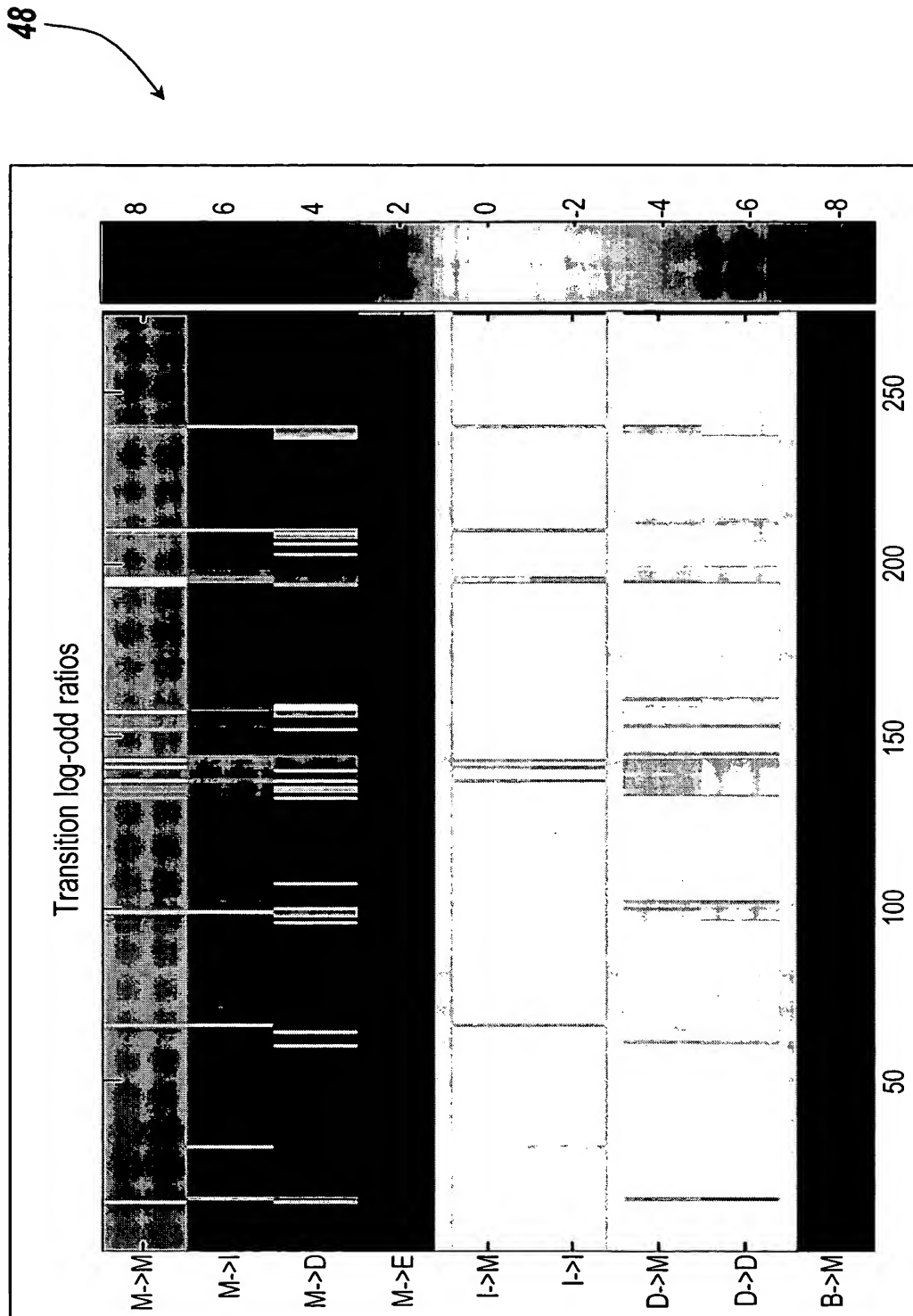


Fig. 6

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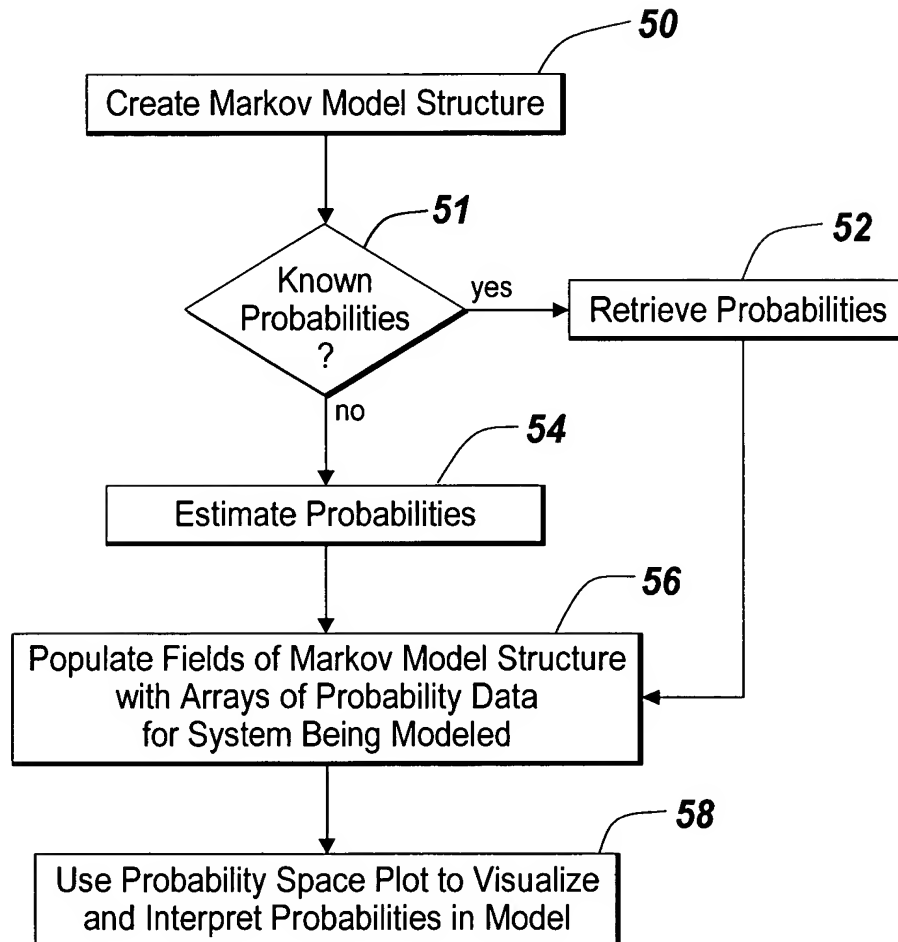


Fig. 7